

June 2009

FDZ197PZ

P-Channel 1.5 V Specified PowerTrench[®] Thin WL-CSP MOSFET -20 V, -3.8 A, 64 m Ω

Features

- Max $r_{DS(on)} = 64 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -2.0 \text{ A}$
- Max $r_{DS(on)} = 71 \text{ m}\Omega$ at $V_{GS} = -2.5 \text{ V}$, $I_D = -2.0 \text{ A}$
- Max $r_{DS(on)} = 79 \text{ m}\Omega$ at $V_{GS} = -1.8 \text{ V}$, $I_D = -1.0 \text{ A}$
- Max $r_{DS(on)}$ = 95 m Ω at V_{GS} = -1.5 V, I_D = -1.0 A
- Occupies only 1.5 mm² of PCB area.Less than 50% of the area of 2 x 2 BGA
- Ultra-thin package: less than 0.65 mm height when mounted to PCR
- HBM ESD protection level > 4400V (Note3)
- RoHS Compliant

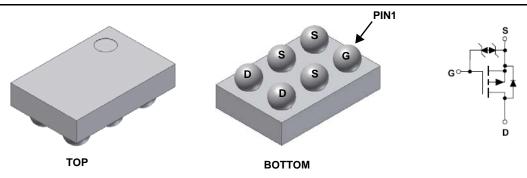


General Description

Designed on Fairchild's advanced 1.5 V PowerTrench® process with state of the art "fine pitch" WLCSP packaging process, the FDZ197PZ minimizes both PCB space and $r_{\text{DS(on)}}.$ This advanced WLCSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge, and low $r_{\text{DS(on)}}.$

Applications

- Battery management
- Load switch
- Battery protection



WL-CSP 1x1.5 Thin

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Param	neter		Ratings	Units
V_{DS}	Drain to Source Voltage			-20	V
V_{GS}	Gate to Source Voltage			±8	V
1	-Continuous	T _A = 25°C	(Note 1a)	-3.8	^
I _D	-Pulsed			-15	— A
D	Power Dissipation	T _A = 25°C	(Note 1a)	1.9	10/
P_{D}	Power Dissipation	$T_A = 25$ °C	(Note 1b)	0.9	W
T _J , T _{STG}	Operating and Storage Junction Temper	ature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	133	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package Reel Size		Tape Width	Quantity
7	FDZ197PZ	WL-CSP 1x1.5 Thin	7 "	8 mm	5000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		-10		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.4	-0.5	-1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		2.7		mV/°C
	$V_{GS} = -4.5 \text{ V}, I_D = -2.0 \text{ A}$		46	64		
	Static Drain to Source On Resistance	$V_{GS} = -2.5 \text{ V}, I_D = -2.0 \text{ A}$		53	71	mΩ
race)		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$		59	79	
r _{DS(on)}	Static Brain to oddrec on registance	$V_{GS} = -1.5 \text{ V}, I_D = -1.0 \text{ A}$		68	95	11122
		$V_{GS} = -4.5 \text{ V}, I_D = -2.0 \text{ A},$ $T_J = 125 \text{ °C}$		54	84	
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_{D} = -3.8 \text{ A}$		21		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40 V V 0 V	1180	1570	pF
C _{oss}	Output Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	190	255	pF
C _{rss}	Reverse Transfer Capacitance		160	225	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			5.8	12	ns
t _r	Rise Time	$V_{DD} = -10 \text{ V}, I_{D} = -3.8 \text{ A},$		5.9	12	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		311	498	ns
t _f	Fall Time			280	448	ns
Q_g	Total Gate Charge	$V_{GS} = 0V \text{ to } -4.5V$ $V_{DD} = -1$	0.17	18	25	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = -1$ $I_{D} = -3.8$	Ο V,	1.5		nC
Q_{gd}	Gate to Drain "Miller" Charge	ID = -3.8		4.7		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.1 \text{ A}$ (Note 2)		-0.6	-1.2	V
t _{rr}	Reverse Recovery Time	F = -3.8 A, di/dt = 100 A/μs		194	310	ns
Q_{rr}	Reverse Recovery Charge			344	550	nC

^{1.} $R_{\theta,IA}$ is determined with the device mounted on a 1 in 2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,IC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 65 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 133 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < $300\mu\text{s},$ Duty cycle < 2.0%.

^{3.} The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

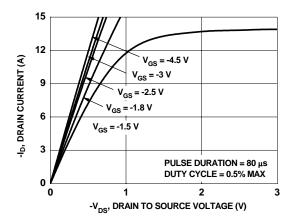


Figure 1. On-Region Characteristics

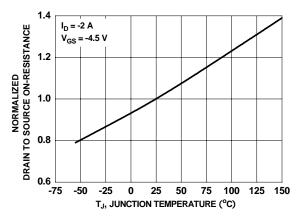


Figure 3. Normalized On-Resistance vs Junction Temperature

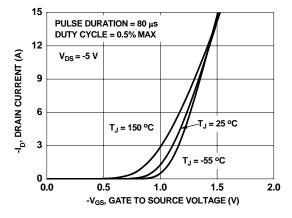


Figure 5. Transfer Characteristics

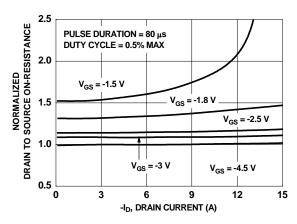


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

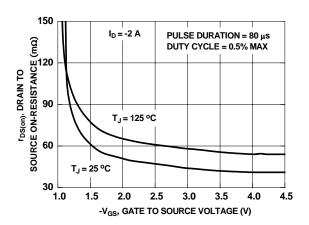


Figure 4. On-Resistance vs Gate to Source Voltage

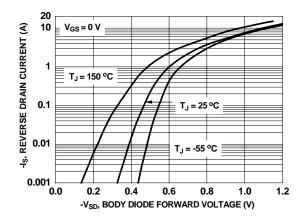


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

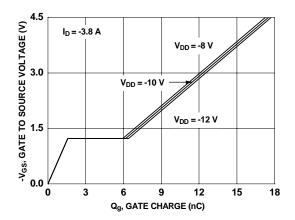


Figure 7. Gate Charge Characteristics

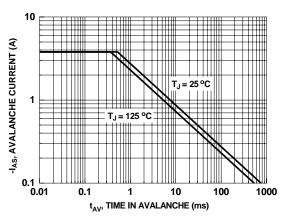


Figure 9. Unclamped Inductive Switching Capability

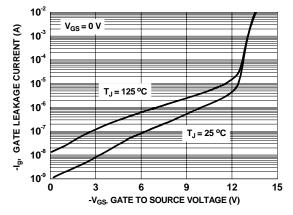


Figure 11. Gate Leakage Current vs Gate to Source Voltage

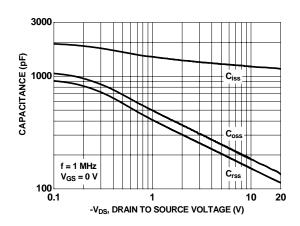


Figure 8. Capacitance vs Drain to Source Voltage

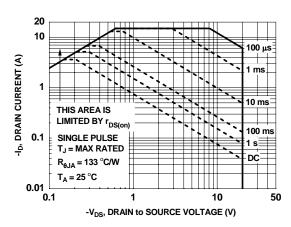


Figure 10. Forward Bias Safe Operating Area

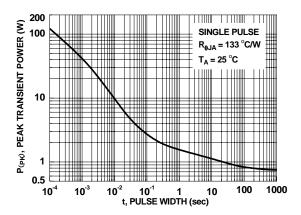


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

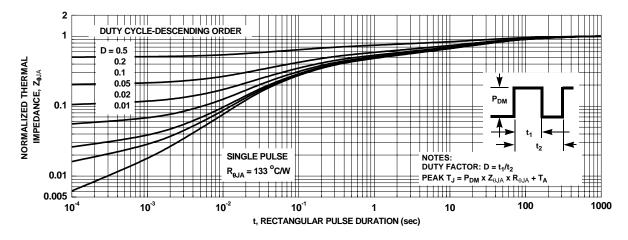
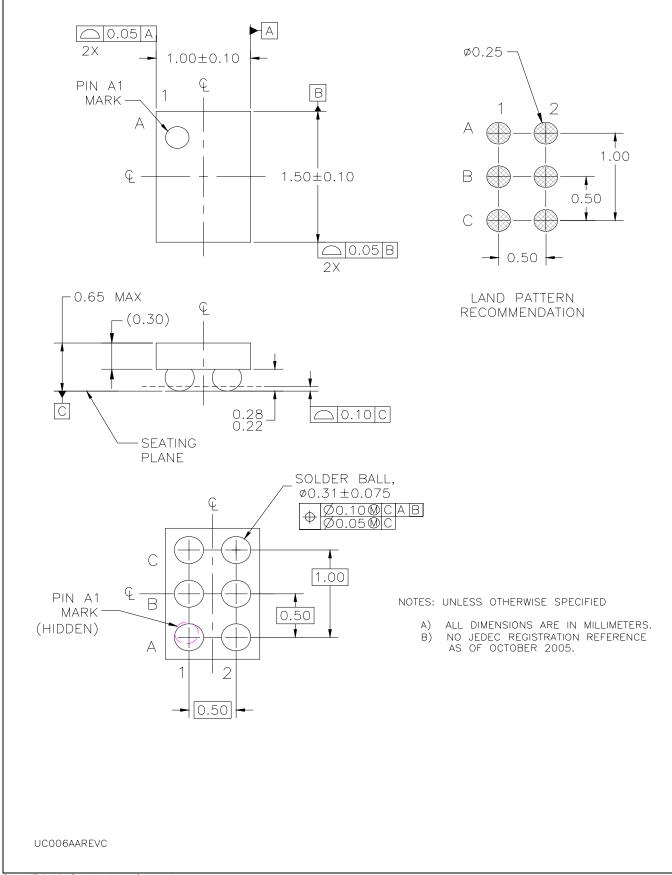


Figure 13. Transient Thermal Response Curve







TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

Auto-SPM™ Build it Now™ CorePLUS™ CorePOWER™ CROSSVOLTTM CTI TM Current Transfer Logic™

EcoSPARK[®] EfficentMax™ EZSWITCH™ *

Fairchild®

Fairchild Semiconductor® FACT Quiet Series™

FACT $\tilde{\mathsf{FAST}^{\mathbb{R}}}$ FastvCore™ FETBench™ FlashWriter® * FPSTM

FRFET®

Global Power ResourceSM Green FPS™ Green FPS™ e-Series™

Gmax™ GTO™ IntelliMAX™ ISOPLANAR™ MegaBuck™ MICROCOUPLER™

MicroFET™ MicroPak™ MillerDrive™ MotionMax™ Motion-SPM™ OPTOLOGIC® OPTOPLANAR®

PDP SPM™ Power-SPM™ PowerTrench® PowerXS^{TI}

Programmable Active Droop™

OFFT⁽ QSTM Quiet Series™ RapidConfigure™

Saving our world, 1mW /W /kW at a time™ SmartMax^{TN}

SMART START™ SPM® STEALTH™ SuperFET™ SuperSOT™-3 SuperSOT™-6

SuperSOT™-8 SupreMOS™ SyncFET™ Sync-Lock™

SYSTEM ® GENERAL

The Power Franchise®

puwer ' TinyBoost™ TinyBuck™ TinyLogic[®] TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™ TriFault Detect™ TRUECURRENT™* μSerDes™

UHC Ultra FRFET™ UniFET™ VCX™ VisualMax™ XSTM

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICYFAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification Product Status		Definition
Advance Information Formative / In Design		Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary First Production		Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 140